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Application/Control No.	Applicant(s)/Patent under Reexamination				
10/710,940	COHN ET AL.				
Examiner	Art Unit				
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Class	Subclass	Date	Examiner
716	4-6, 8, 12-14, 18	5/25/2006	PD
714	726-727	5/25/2006	PD
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INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
716	4,18	5/25/2005	PD		
714	726	5/25/2005	PD		

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EAST		5/25/2006	PD
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